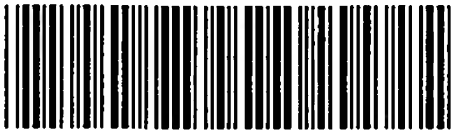


<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/710,351	JOSEPH, MARK	
	Examiner	Art Unit	
	David J. Makiya	2885	

SEARCHED			
Class	Subclass	Date	Examiner
362	147	3/7/2007	DJM
	648		
	148		
	429		
439	110	3/7/2007	DJM
	120		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
362	147	3/7/2007	DJM
	148,648		
439	110,120	3/7/2007	DJM
Interference test search attached		3/7/2007	DJM

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated search in EAST attached	3/7/2007	DJM
Inventor name search	3/7/2007	DJM
Consulated Jacob Choi regarding allowable subject matter	3/5/2007	DJM